N-Channel Power MOSFET 620 V, 2.0 Ω

Features

- Low ON Resistance
- Low Gate Charge
- ESD Diode-Protected Gate
- 100% Avalanche Tested
- These Devices are Pb–Free, Halogen Free/BFR Free and are RoHS Compliant

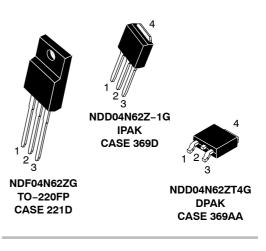


ON Semiconductor®

http://onsemi.com

V _{DSS}	R _{DS(ON)} (MAX) @ 2 A
620 V	2.0 Ω

N-Channel D (2) O



ORDERING INFORMATION

See detailed ordering and shipping information in the package dimensions section on page 6 of this data sheet.

ABSOLUTE MAXIMUM RATINGS (T_C = 25°C unless otherwise noted)

Parameter	Symbol	NDF	NDD	Unit
Drain-to-Source Voltage	V _{DSS}	620		V
Continuous Drain Current $R_{\theta JC}$	۱ _D	4.4 (Note 2)	4.1	A
Continuous Drain Current $R_{\theta JC}$, $T_A = 100^{\circ}C$	۱ _D	2.8 (Note 2)	2.6	A
Pulsed Drain Current, V _{GS} @ 10V	I _{DM}	18 (Note 2)	16	A
Power Dissipation $R_{\theta JC}$ (Note 1)	PD	28	83	W
Gate-to-Source Voltage	V _{GS}	±30		V
Single Pulse Avalanche Energy, $I_D = 4.0 \text{ A}$	E _{AS}	120		mJ
ESD (HBM) (JESD22-A114)	V _{esd}	3000		V
RMS Isolation Voltage (t = 0.3 sec., R.H. ≤ 30%, T _A = 25°C) (Figure 14)	V _{ISO}	4500	-	V
Peak Diode Recovery	dv/dt	4.5 (No	te 3)	V/ns
Continuous Source Current (Body Diode)	۱ _S	4.0		A
Maximum Temperature for Soldering Leads, 0.063" (1.6 mm) from Case for 10 s Package Body for 10 s	T _L T _{PKG}	300 260		°C
Operating Junction and Storage Temperature Range	T _J , T _{stg}	–55 to	150	°C

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

- Surface mounted on FR4 board using 1" sq. pad size (Cu area = 1.127 in sq [2 oz] including traces).
- 2. Limited by maximum junction temperature
- 3. $I_{SD} = 4.0$ Å, di/dt ≤ 100 Å/ μ s, $V_{DD} \leq BV_{DSS}$, $T_J = +150^{\circ}C$

This document contains information on some products that are still under development. ON Semiconductor reserves the right to change or discontinue these products without notice.

THERMAL RESISTANCE

Parameter		Symbol	Value	Unit
Junction-to-Case (Drain)	NDF04N62Z NDD04N62Z	$R_{\theta JC}$	4.4 1.5	°C/W
Junction-to-Ambient Steady State	(Note 4) NDF04N62Z (Note 1) NDD04N62Z (Note 4) NDD04N62Z-1	$R_{ hetaJA}$	50 38 80	

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise noted)

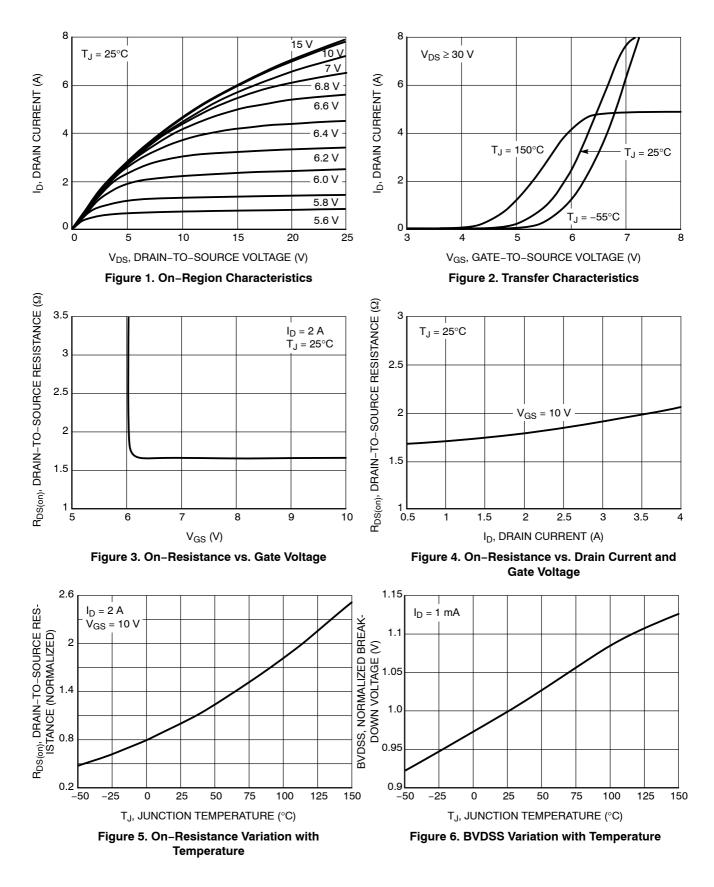
Characteristic	Test Conditions		Symbol	Min	Тур	Max	Unit
OFF CHARACTERISTICS							-
Drain-to-Source Breakdown Voltage	V _{GS} = 0 V, I _D = 1 mA		BV _{DSS}	620			V
Breakdown Voltage Temperature Coefficient	Reference to 25°C, $I_D = 1 \text{ mA}$		$\Delta BV_{DSS}/\Delta T_{J}$		0.6		V/°C
Drain-to-Source Leakage Current		25°C	I _{DSS}			1	μA
	V _{DS} = 620 V, V _{GS} = 0 V	125°C				50	
Gate-to-Source Forward Leakage	V _{GS} = ±20 V	1	I _{GSS}			±10	μA
ON CHARACTERISTICS (Note 5)	•				-	-	
Static Drain-to-Source On-Resistance	V _{GS} = 10 V, I _D = 2.0 A	A	R _{DS(on)}		1.8	2.0	Ω
Gate Threshold Voltage	V _{DS} = V _{GS} , I _D = 50 μ/	A	V _{GS(th)}	3.0		4.5	V
Forward Transconductance	V _{DS} = 15 V, I _D = 2.0 A	۸	9 _{FS}		3.3		S
OYNAMIC CHARACTERISTICS	•				-	-	
Input Capacitance			C _{iss}		535		pF
Output Capacitance	V _{DS} = 25 V, V _{GS} = 0 \ f = 1.0 MHz	/,	C _{oss}		62		
Reverse Transfer Capacitance					14		
Total Gate Charge			Qg		19		nC
Gate-to-Source Charge	V _{DD} = 310 V, I _D = 4.0 /	۹,	Q _{gs}		3.9		
Gate-to-Drain ("Miller") Charge	V _{GS} = 10 V		Q _{gd}		10		
Plateau Voltage			V _{GP}		6.4		V
Gate Resistance			Rg		4.7		Ω
RESISTIVE SWITCHING CHARACTER	ISTICS						-
Turn-On Delay Time			t _{d(on)}		12		ns
Rise Time	V _{DD} = 310 V, I _D = 4.0 /	۹,	t _r		13		
Turn-Off Delay Time	V _{GS} = 10 V, R _G = 5 Ω	2	t _{d(off)}		25		
Fall Time			t _f		14		1
SOURCE-DRAIN DIODE CHARACTER	RISTICS (T _C = 25°C unless othe	erwise not	ed)		-	-	-
Diode Forward Voltage	I _S = 4.0 A, V _{GS} = 0 V		V _{SD}			1.6	V

Diode Forward Voltage	$I_{S} = 4.0 \text{ A}, V_{GS} = 0 \text{ V}$	V _{SD}		1.6	V
Reverse Recovery Time	V_{GS} = 0 V, V_{DD} = 30 V	t _{rr}	285		ns
Reverse Recovery Charge	$I_{S} = 4.0 \text{ A}, \text{ di/dt} = 100 \text{ A/}\mu\text{s}$	Q _{rr}	1.3		μC

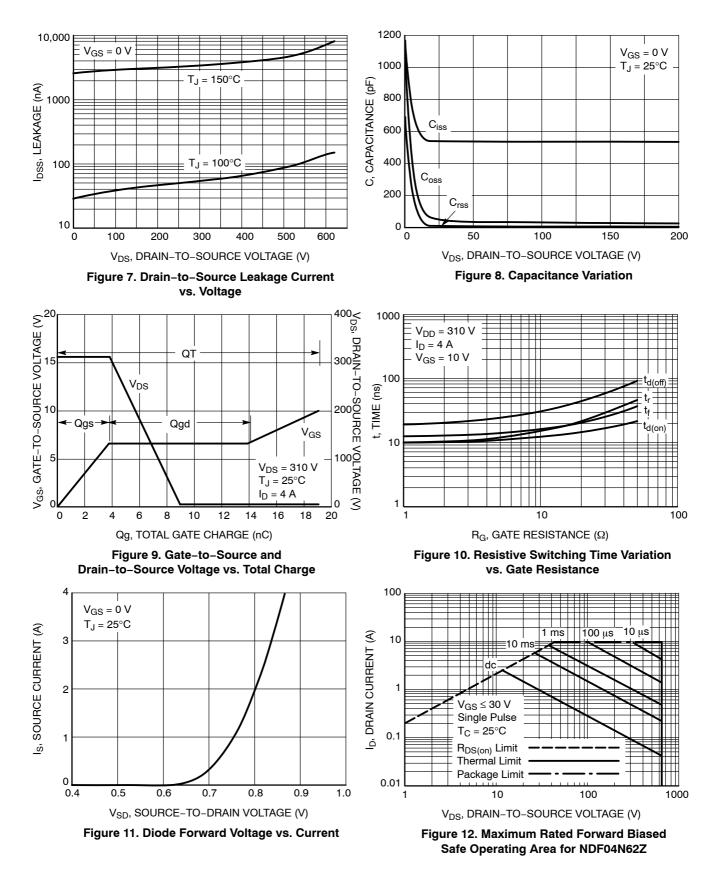
4. Insertion mounted

5. Pulse Width \leq 380 μ s, Duty Cycle \leq 2%.

TYPICAL CHARACTERISTICS



TYPICAL CHARACTERISTICS



TYPICAL CHARACTERISTICS

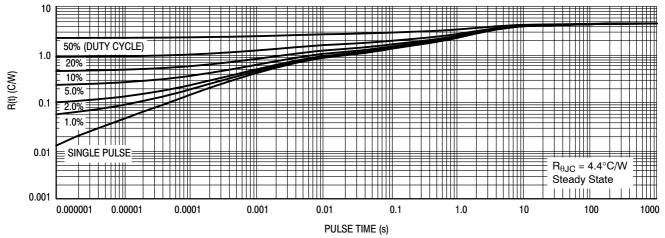
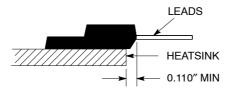


Figure 13. Thermal Impedance for NDF04N62Z





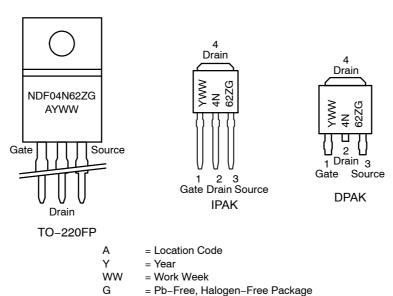
Measurement made between leads and heatsink with all leads shorted together.

*For additional mounting information, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

ORDERING INFORMATION

Order Number	Package	Shipping [†]
NDF04N62ZG	TO-220FP (Pb-Free, Halogen-Free)	50 Units / Rail
NDD04N62Z-1G	IPAK (Pb-Free, Halogen-Free)	75 Units / Rail (In Development)
NDD04N62ZT4G	DPAK (Pb-Free, Halogen-Free)	2500 / Tape & Reel (In Development)

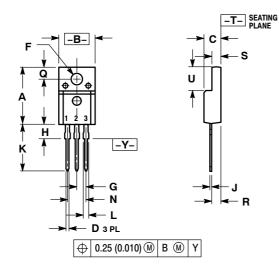
†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.



MARKING DIAGRAMS

PACKAGE DIMENSIONS

TO-220FP CASE 221D-03 ISSUE K

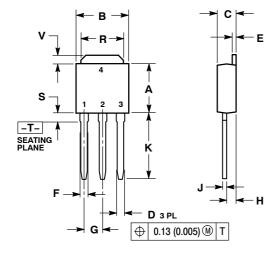


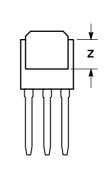
NOTES: 1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982. 2. CONTROLLING DIMENSION: INCH 3. 221D-01 THRU 221D-02 OBSOLETE, NEW STANDARD 221D-03.

	INCHES		MILLIN	IETERS
DIM	MIN	MAX	MIN	MAX
Α	0.617	0.635	15.67	16.12
В	0.392	0.419	9.96	10.63
С	0.177	0.193	4.50	4.90
D	0.024	0.039	0.60	1.00
F	0.116	0.129	2.95	3.28
G	0.100	BSC	2.54	BSC
Н	0.118	0.135	3.00	3.43
J	0.018	0.025	0.45	0.63
K	0.503	0.541	12.78	13.73
L	0.048	0.058	1.23	1.47
Ν	0.200 BSC		5.08	BSC
Q	0.122	0.138	3.10	3.50
R	0.099	0.117	2.51	2.96
S	0.092	0.113	2.34	2.87
U	0.239	0.271	6.06	6.88

PIN 1. GATE 2. DRAIN 3. SOURCE

IPAK CASE 369D-01 ISSUE C





NOTES: 1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982. 2. CONTROLLING DIMENSION: INCH.

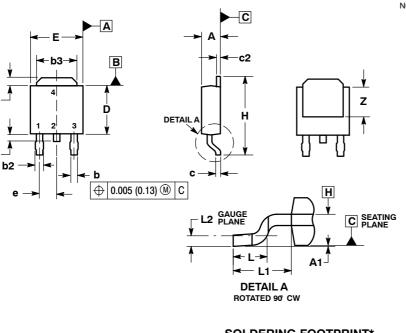
	INCHES		MILLIN	IETERS
DIM	MIN	MAX	MIN	MAX
Α	0.235	0.245	5.97	6.35
В	0.250	0.265	6.35	6.73
С	0.086	0.094	2.19	2.38
D	0.027	0.035	0.69	0.88
Е	0.018	0.023	0.46	0.58
F	0.037	0.045	0.94	1.14
G	0.090) BSC	2.29 BSC	
Н	0.034	0.040	0.87	1.01
J	0.018	0.023	0.46	0.58
к	0.350	0.380	8.89	9.65
R	0.180	0.215	4.45	5.45
S	0.025	0.040	0.63	1.01
V	0.035	0.050	0.89	1.27
Ζ	0.155		3.93	

STYLE 2: PIN 1. GATE 2. DRAIN 3. SOURCE

4. DRAIN

PACKAGE DIMENSIONS

DPAK (SINGLE GUAGE) CASE 369AA-01 **ISSUE B**

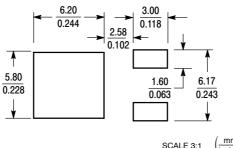


NOTES:

- 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994
- 2. CONTROLLING DIMENSION: INCHES. 3. THERMAL PAD CONTOUR OPTIONAL WITHIN DI-MENSIONS b3, L3 and Z. 4. DIMENSIONS D AND E DO NOT INCLUDE MOLD
- FLASH, PROTRUSIONS, OR BURRS, MOLD FLASH, PROTRUSIONS, OR GATE BURRS SHALL
- DATURSIONS D AND E ARE DETERMINED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY.
 DATUMS A AND B ARE DETERMINED AT DATUM
- PLANE H.

	INC	HES	MILLIN	IETERS
DIM	MIN	MAX	MIN	MAX
Α	0.086	0.094	2.18	2.38
A1	0.000	0.005	0.00	0.13
b	0.025	0.035	0.63	0.89
b2	0.030	0.045	0.76	1.14
b3	0.180	0.215	4.57	5.46
c	0.018	0.024	0.46	0.61
c2	0.018	0.024	0.46	0.61
D	0.235	0.245	5.97	6.22
ш	0.250	0.265	6.35	6.73
e	0.090 BSC		2.29	BSC
Н	0.370	0.410	9.40	10.41
Г	0.055	0.070	1.40	1.78
L1	0.108 REF		2.74	REF
L2	0.020	BSC	0.51 BSC	
L3	0.035	0.050	0.89	1.27
L4		0.040		1.01
Ζ	0.155		3.93	

SOLDERING FOOTPRINT*



STYLE 2: PIN 1. GATE 2. DRAIN 3. SOURCE

4. DRAIN

mm SCALE 3:1 inche *For additional information on our Pb-Free strategy and soldering

details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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